

## **FX607**

# N-Channel Silicon MOSFET Ultrahigh-Speed Switching, Motor Driver Applications

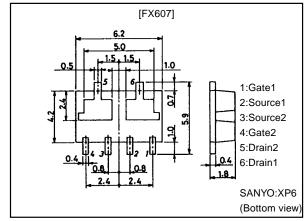
#### **Features**

- · Composite type composed of two low ON-resistance N-channel MOSFET chips for ultrahigh-speed switching and low-voltage drive.
- · Facilitates high-density mounting.
- The FX607 is formed with two chips, each being equivalent to the 2SK2260, placed in one package.
- · Matched pair characteristics.

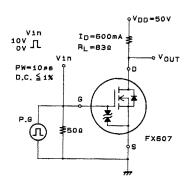
#### **Package Dimensions**

unit:mm

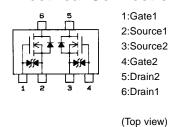
2120



#### **Switching Time Test Circuit**



### **Electrical Connection**



#### **Specifications**

#### Absolute Maximum Ratings at Ta = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Drain-to-Source Voltage	V <sub>DSS</sub>		150	V
Gate-to-Source Voltage	V <sub>GSS</sub>		±20	V
Drain Current (DC)	I <sub>D</sub>		1.2	Α
Drain Current (Pulse)	I <sub>DP</sub>	PW≤10µs, duty cycle≤1%	4.8	Α
Allowable Power Dissipation	PD	Tc=25°C, 1 unit	6	W
	PD	Mounted on ceramic board (750mm <sup>2</sup> ×0.8mm) 1 unit	1.5	W
Total Dissipation	PT	Mounted on ceramic board (750mm <sup>2</sup> ×0.8mm)	2	W
Channel Temperature	Tch		150	°C
Storage Temperature	Tstg		-55 to +150	°C

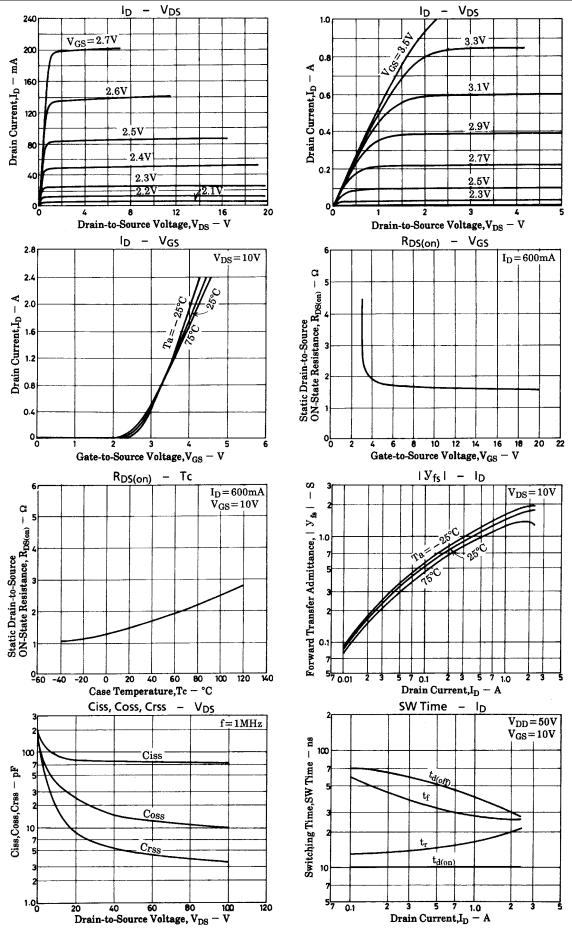
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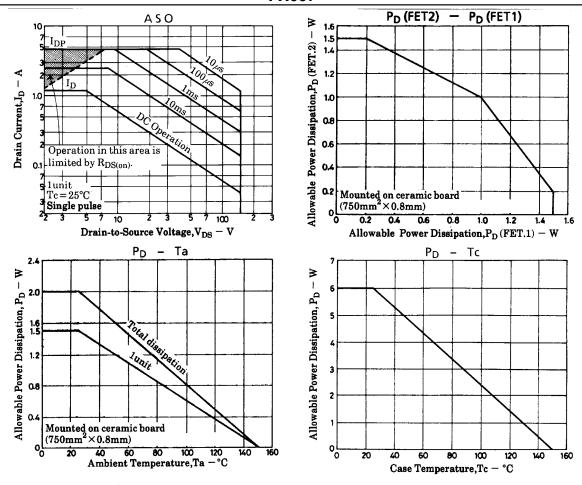
## FX607

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#### Electrical Characteristics at Ta = 25°C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	Offic
D-S Breakdown Voltage	V(BR)DSS	I <sub>D</sub> =1mA, V <sub>GS</sub> =0	150			V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =150V, V <sub>GS</sub> =0			100	μΑ
Gate-to-Source Leakage Current	IGSS	V <sub>GS</sub> =±18V, V <sub>DS</sub> =0			±10	μΑ
Cutoff Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> =10V, ID=1mA	1.5		2.5	V
Forward Transfer Admittance	Yfs	V <sub>DS</sub> =10V, I <sub>D</sub> =600mA	0.8	1.1		S
Static Drain-to-Source ON-State Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =600mA, V <sub>GS</sub> =10V		1.6	2.2	Ω
Input Capacitance	Ciss	V <sub>DS</sub> =20V, f=1MHz		80		pF
Output Capacitance	Coss	V <sub>DS</sub> =20V, f=1MHz		25		pF
Reverse Transfer Capacitance	Crss	V <sub>DS</sub> =20V, f=1MHz		8.5		pF
Turn-ON Delay Time	t <sub>d(on)</sub>	See specified Test Circuit		10		ns
Rise Time	t <sub>r</sub>	See specified Test Circuit		15		ns
Turn-OFF Delay Time	t <sub>d</sub> (off)	See specified Test Circuit		50		ns
Fall Time	t <sub>f</sub>	See specified Test Circuit		30		ns
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =1.2A, V <sub>GS</sub> =0		1.0		V





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